

Temperature Variation

The Unappreciated Environmental Factor in the Stability of Multigigabit Automotive Ethernet

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Vehicles operate

in the extremes



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Two types of temperature tests

Static tests



"Error-free" links at any valid temperature

Ramp tests



"Error-free" as temperature ramps across range

Static testing process is well-defined

- PHY links without error at any valid temperature
- The underlying standard provides a limit on cable/board electrical characteristics
 - For all temperatures, the cable/board should not violate these requirements on insertion loss, return loss, jitter, etc.

Ramp testing is well-defined, too, but to get good results...hard



What's so hard about passing a ramp test?



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First things first: measurement setup

- 15m shielded twisted pair with four inline connectors
- Temperature range: -40° to 105° Celsius



Channel insertion loss increases with temperature



Source: Marvell

How do we address insertion loss variability?



Addressing insertion loss variability increases chip size, power and cost

Cable delay varies with temperature



Delay variation ~1.7 symbol duration of 10GBASE-T1

Source: Marvell

How do we address channel delay variability?



Addressing delay variability increases chip size, power and cost

Return loss over temperature is unpredictable



Source: Marvell

How do we address channel return loss variability?



Addressing insertion loss variability increases chip size, power and cost

Summary: passing the temperature ramp test





So, we can fix it, right?



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Not so fast...

MDJ 25L

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Insertion loss over temp varies by cable brand



Source: Marvell

Call to action

To create more economical, reliable Ethernet Solutions

We need to define reasonable min and max boundaries for cable performance over temperature

Common mode to differential gain varies over temp



Varying temp affects the behavior of device in ElectroMagnetic Interference test

Key takeaways

	Insertion loss and related metrics exhibit high variability over temperature
2	Degree of temperature-induced variability differs between cable brands
3	Penalties are steep for overdesigning PHYs to accommodate max variability
4	Min/max limits should be established for performance variability over temp



Thank You



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Special thanks

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